

Search Notes

Application/Control No.

10/023,069

Examiner

Richard Lee

Applicant(s)/Patent under
Reexamination

YAN ET AL.

Art Unit

2613

SEARCHED

Class	Subclass	Date	Examiner
Updated	Search	1/18/2006	RL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR